Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,100	CRUDELE ET AL.	
Examiner	Art Unit	
Jude J. Jean-Gilles	2143	

SEARCHED						
Class	Subclass	Date	Examiner			
709	224-226 316 328	4/6/2006	JG			
345	745 762	4/6/2006	JG			
717	120 170	4/6/2006	JG			
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INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			
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- SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
PAM tool: Effective filing Date Double Ptenting	4/6/2006	JG		
EAST tool: DERWENT USPAT EPO JPO	4/6/2006	JG		
Internet: NPLs IEEE google.com onelook.com	4/6/2006	JG		
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